

# Laboratory characterization of 3D-trench silicon pixel sensors with a $^{90}\text{Sr}$ radioactive source

Michela Garau  
on behalf of the TimeSPOT team

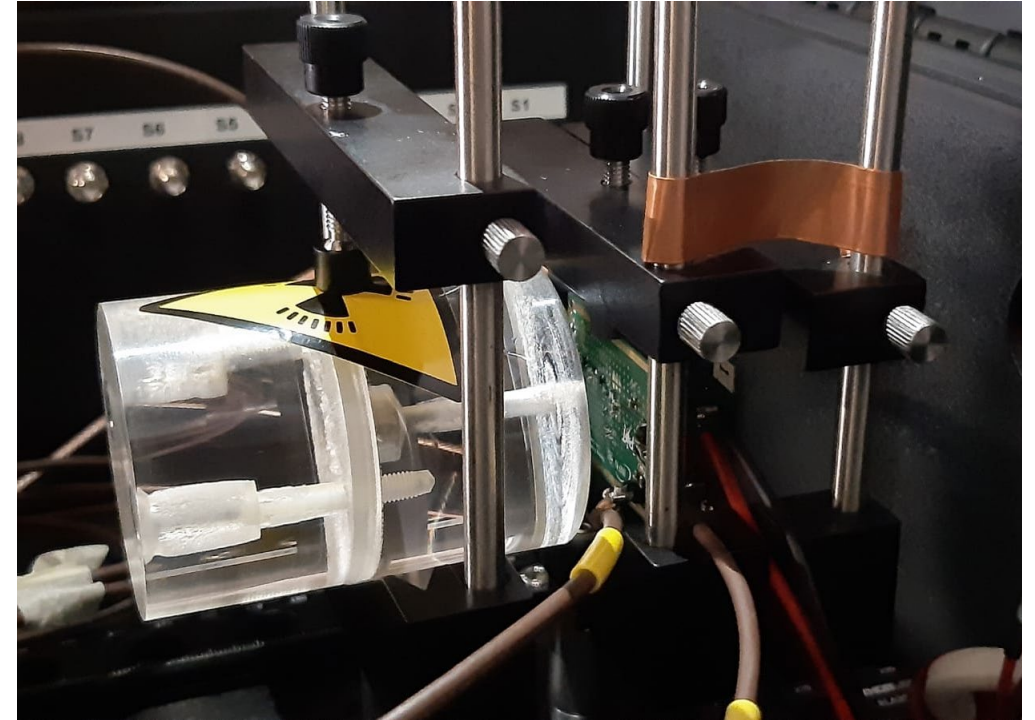
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16th (Virtual) Trento Workshop on Advanced Silicon Radiation Detectors



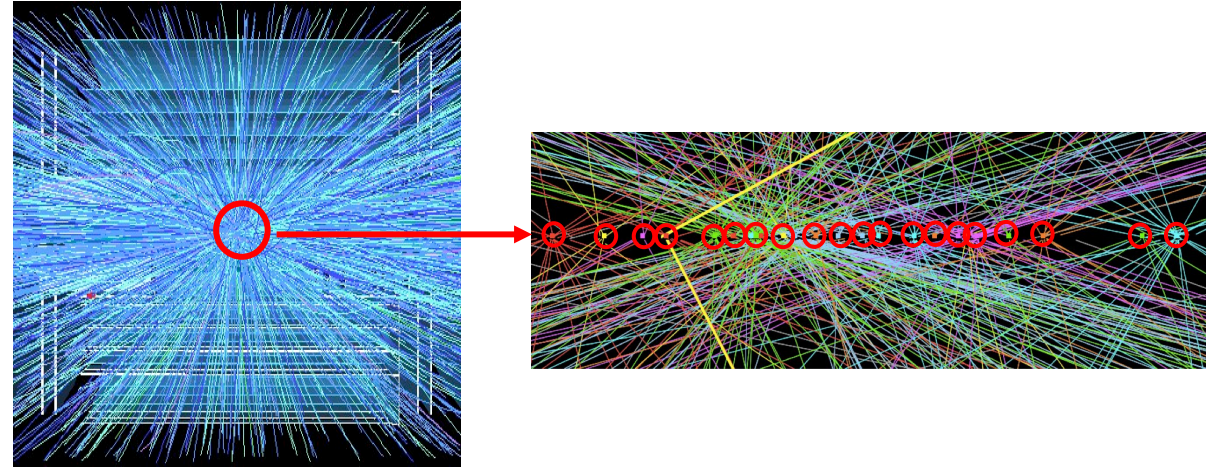
# Outline

- High Luminosity at LHC
- The TimeSPOT 3D-trench pixel sensors
- Beam test like setup with a  $^{90}\text{Sr}$  source
- Results
- Conclusions



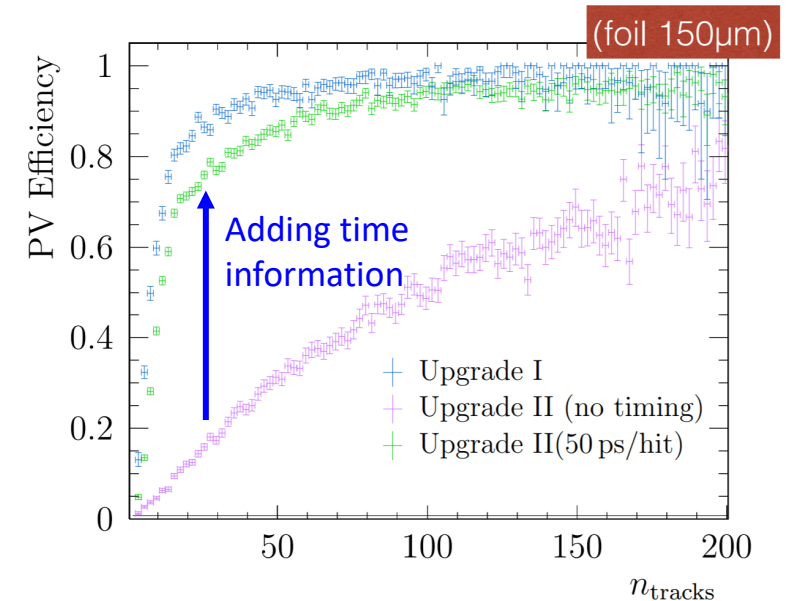
# High Luminosity at LHC

- Extremely high instantaneous luminosity at upgraded LHC and future colliders
  - very **high radiation damage** to tracking detectors
  - very **difficult event reconstruction** due to large pile-up  
→ addition of the **time information** per hit/track
- LHCb Upgrade-2 requirements:
  - Fluence  $10^{16} - 10^{17}$  1 MeV  $n_{eq}/cm^2$
  - $\sigma_t \approx 30 - 50$  ps per hit
  - $\sigma_s \approx 10$   $\mu m$



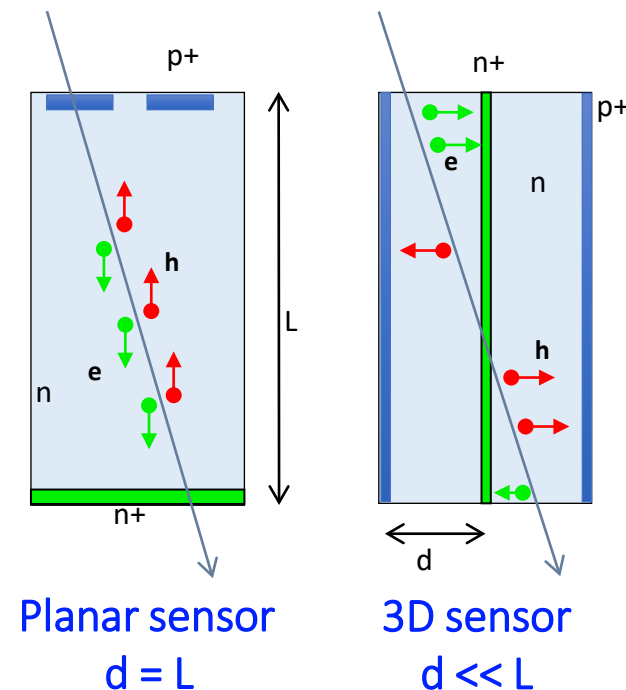
Very good spatial and time resolution,  
high radiation hardness are required  
**at the same time!**

**3D technology is a very promising option**



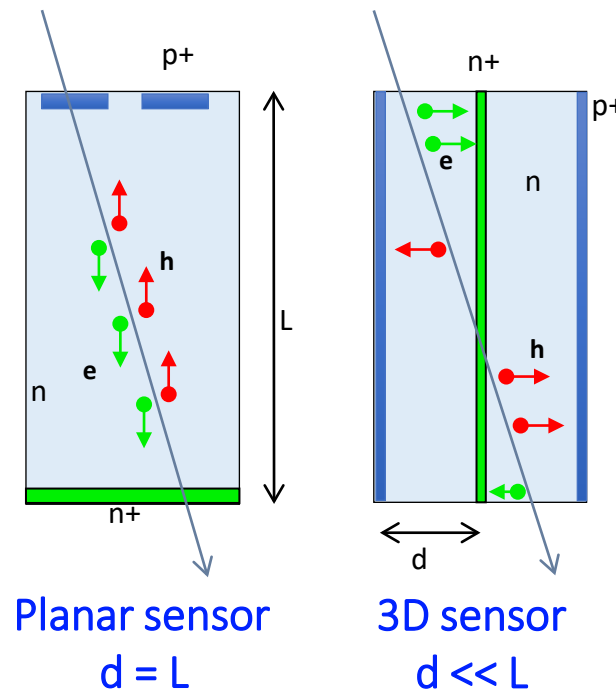
# Why 3D sensors for fast timing?

- Proposed for the first time in 1997 by Sherwood Parker (S.I. Parker et al., NIMA 395(1997) 328)
- Short inter-electrode distance ( $d \ll L$ ) → extremely fast signals
- Unmatched radiation hardness  $> 10^{17}$  1 MeV  $n_{eq}/cm^2$  (M. Manna et al., NIMA 979(2020) 164458)
- 3D columnar geometry sensors already used (e.g. ATLAS IBL)
- The optimization of active volume and electrodes shape is possible



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- 4 years INFN-funded project
- Innovative 3D pixel sensors + readout
  - space resolution  $O(10 \mu m)$
  - time resolution  $< 50$  ps per pixel
  - radiation hardness  $> 10^{16}$  1 MeV  $n_{eq}/cm^2$



# The ~~TimeSPOT~~ sensor design



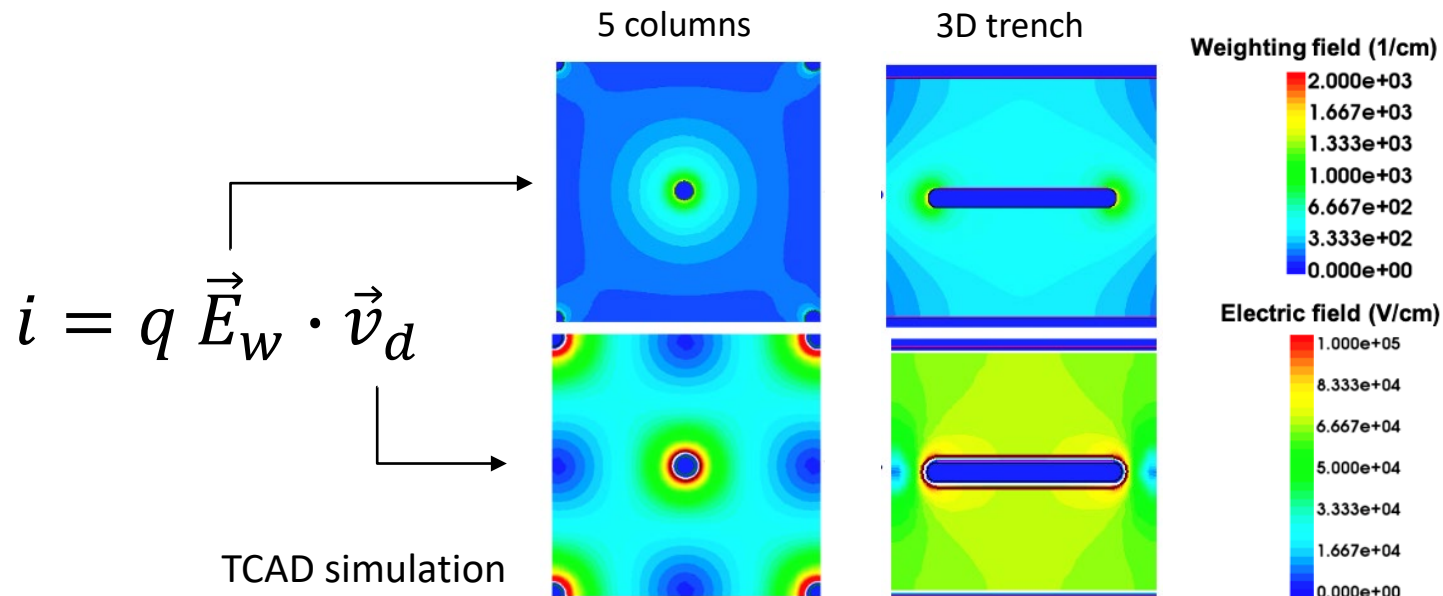
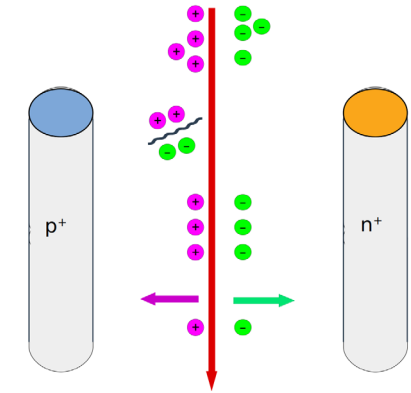
In a semiconductor detector the **signal**, due to the passage of a charged particle, is produced by the drift of the charge carriers, which induces on the electrodes an **instantaneous current**  $i$  defined as

$$i = q \vec{E}_w \cdot \vec{v}_d$$

$E_w$  = weighting field,  $v_d$  = carrier's drift velocity

We want a detector in which the **signals** are **position independent**

$\vec{E}_w \cdot \vec{v}_d$  has to be **as uniform as possible**

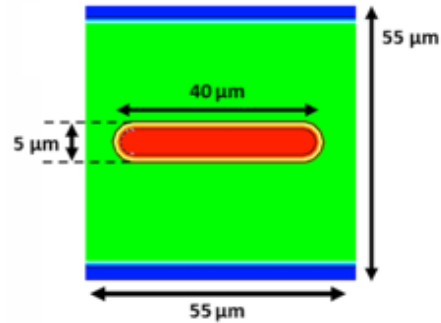
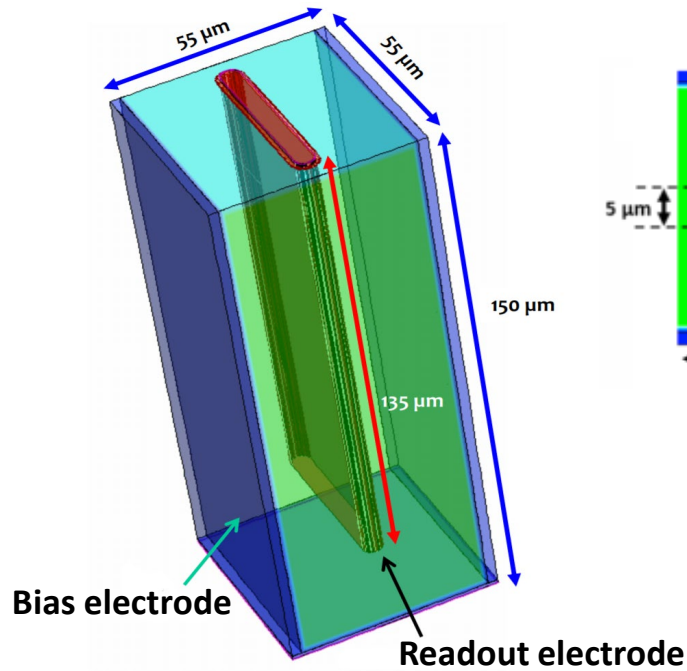


Weighting field and electric field maps **much more uniform** in the **trench geometry**

↓  
This implies a fast and more uniform charge collection time

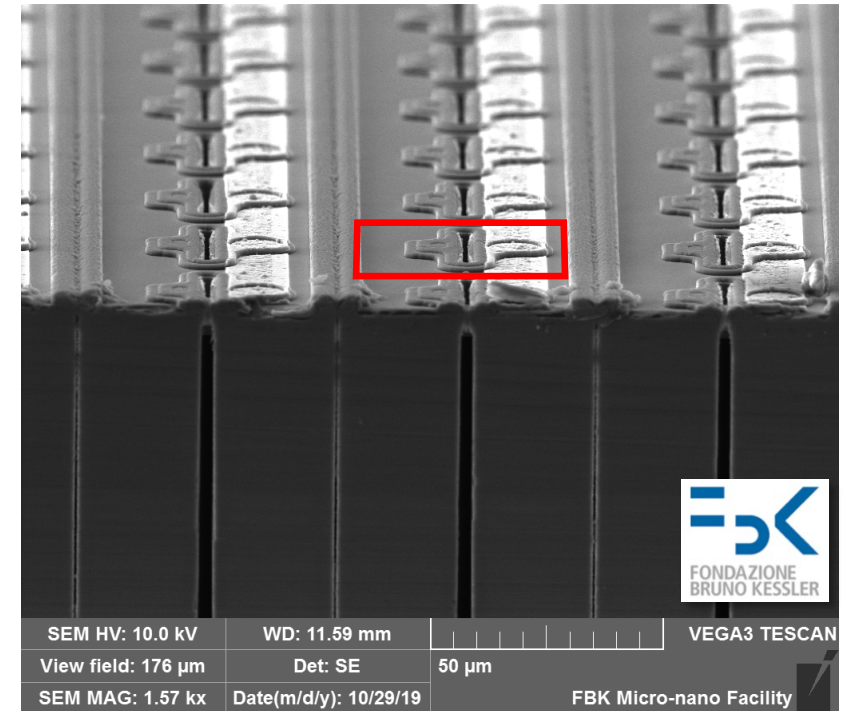
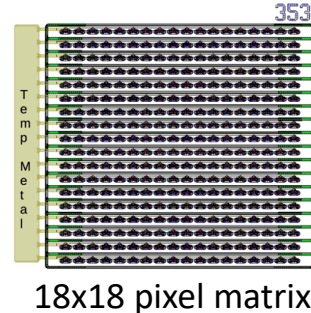
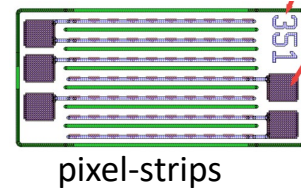
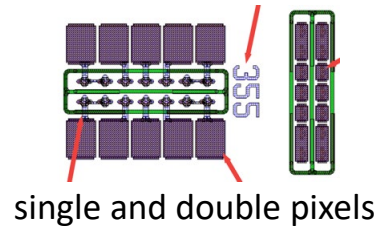
# The **TimeSPOT** sensors

*TIME and SPace real-time Operating Tracker*

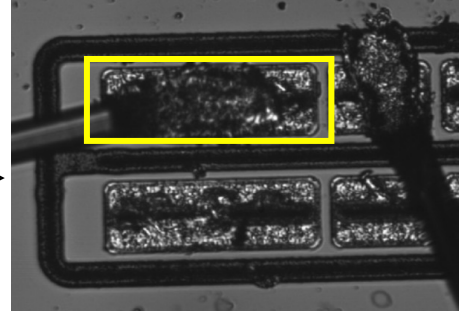
- 55x55 μm<sup>2</sup> pixels
- 150 μm active thickness
- Collection electrode 135 μm deep

- The **first batch** of TimeSPOT sensors was produced in **2019** at Fondazione Bruno Kessler (FBK, Trento, Italy)
- Several devices designed and fabricated (single and double pixels, 10 pixel-strips, 18x18 and 256x256 pixel matrices, etc.)

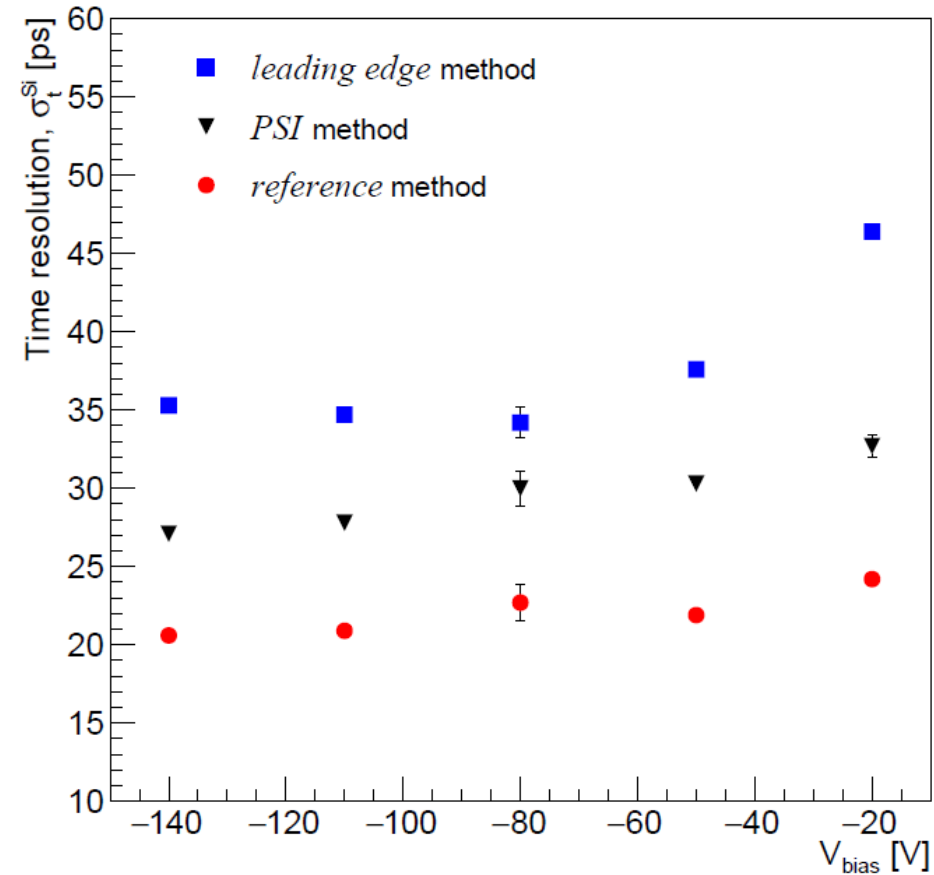
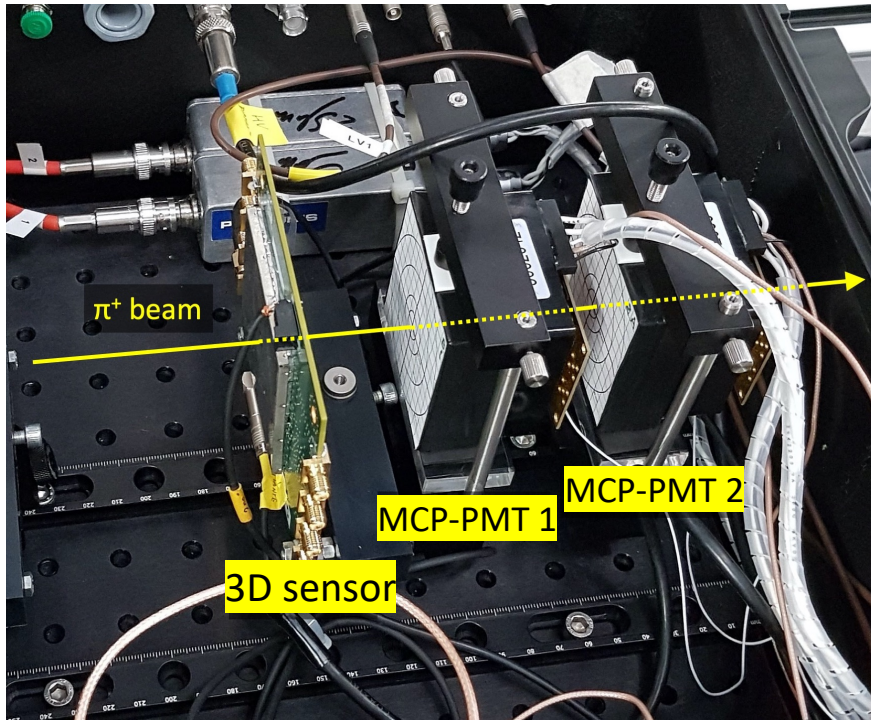


# The first TimeSPOT beam test

- Paul Scherrer Institut (PSI)  $\pi^+$ M1
- $\pi^+$  beam,  $270 \text{ MeV}/c$
- Structure tested: **double pixel**



L. Anderlini et al., "Intrinsic time resolution of 3D-trench silicon pixels for charged particle detection", 2020 JINST 15 P09029 <https://doi.org/10.1088/1748-0221/15/09/P09029>



Time accuracy of the time reference  $\sim 12 \text{ ps}$



# Time resolution contributions

At a first order simplified analysis, the time resolution of a system sensor + read-out electronics is

$$\sigma_t = \sqrt{\sigma_{tw}^2 + \sigma_{dr}^2 + \sigma_{un}^2 + \sigma_{ej}^2 + \sigma_{TDC}^2}$$

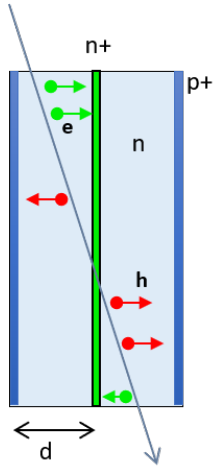
~~$\sigma_{tw}$~~ : signal amplitude fluctuation event by event → time-walk jitter → constant fraction discriminator

~~$\sigma_{dr}$~~ : delta rays → signal amplitude and shape variations → negligible in a 3D sensor

$\sigma_{un}$ : non-uniformities in the charge collecting field and carrier velocities → different signal shape

$\sigma_{ej}$ : noise of the preamplifier used to readout the sensor

~~$\sigma_{TDC}$~~ : digital resolution of the electronics used to measure the signal → adequate TDC



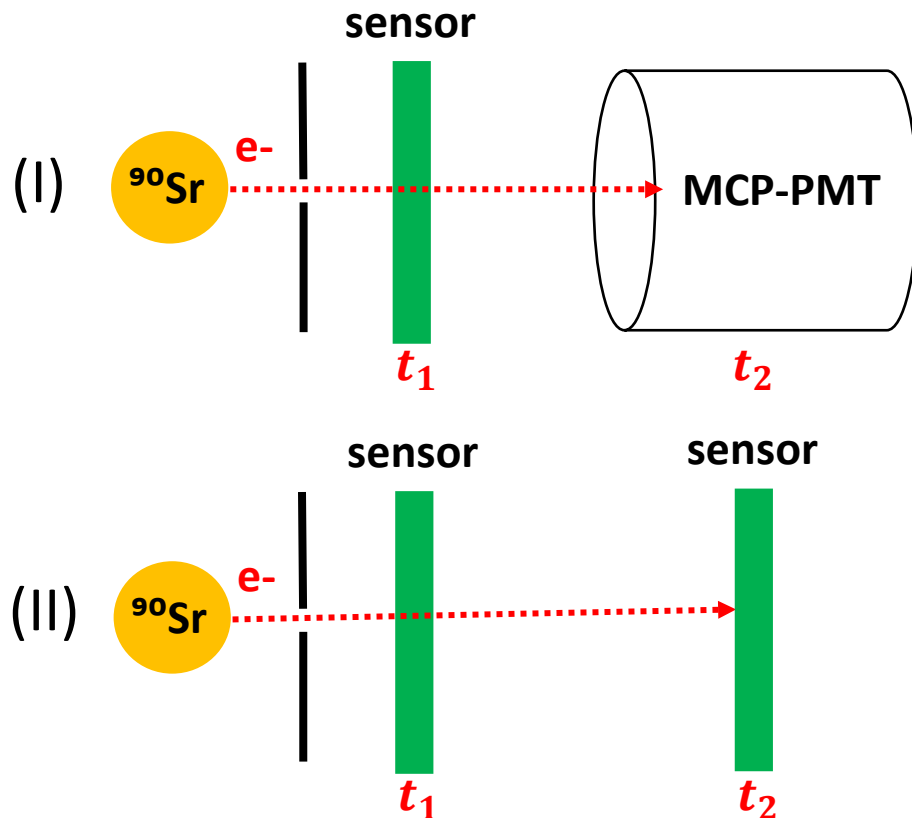
For a 3D sensor



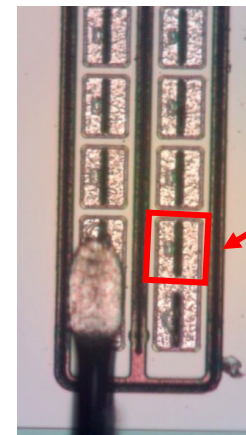
$$\sigma_t \cong \sqrt{\sigma_{un}^2 + \sigma_{ej}^2}$$

# Beam test setup in laboratory

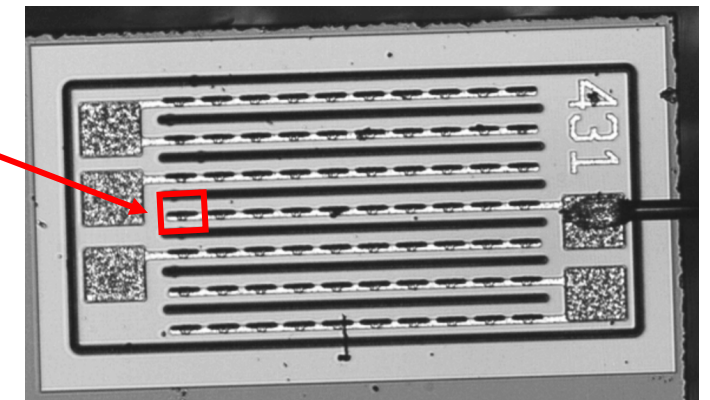
- To perform accurate time resolution measurements **in our laboratory** with minimum ionizing particles
- Beta emitter  $^{90}\text{Sr}$ , (0.546 - 2.28) MeV
- Two setup configurations:
  - (I) with an external time reference detector
  - (II) measure of the time of arrival in one sensor with respect to another



- Test structures tested:
  - double pixel
  - pixel strip (not measured at the PSI 2019 beam test)



Double pixel

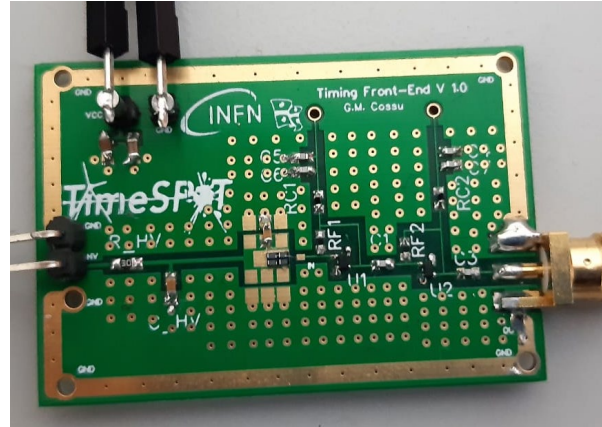


Pixel strip

# Setup I

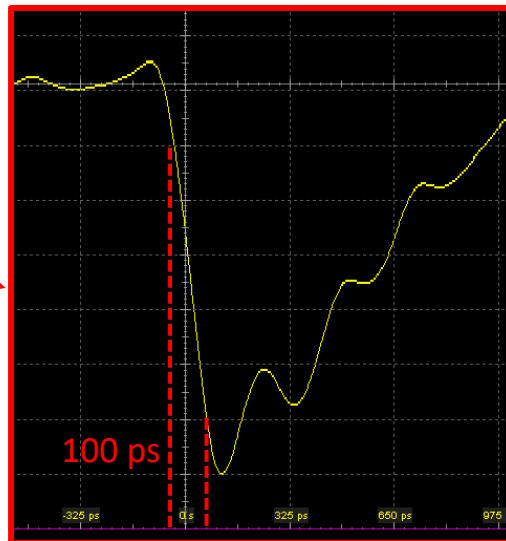
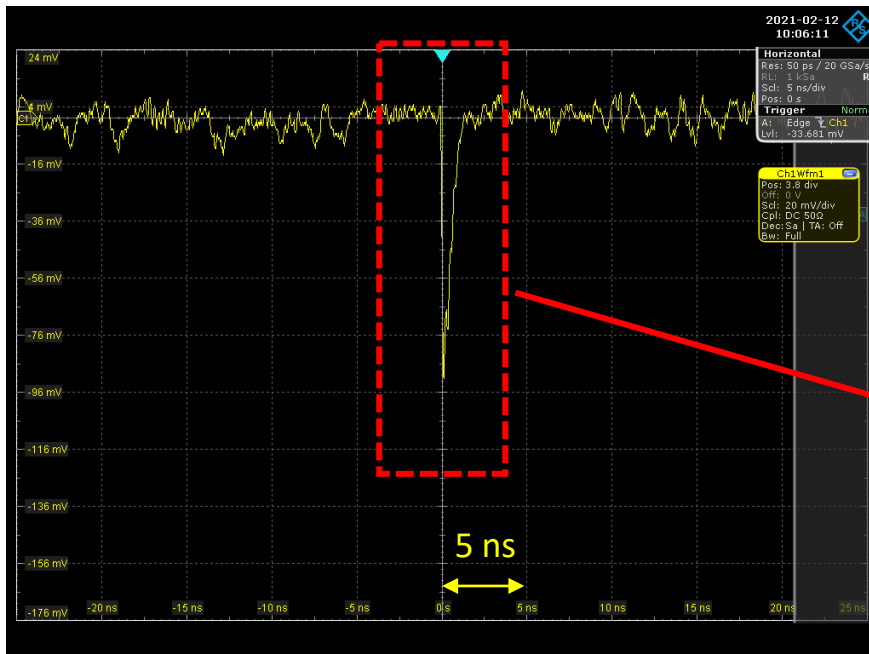
## FEE electronic board

- FEE optimised for the TimeSPOT sensor
- Two stages of transimpedance amplifier with ultra low-noise SiGe BJT
- Noise  $\sim 3$  mV
- Rise time  $\sim 100$  ps



## Time reference

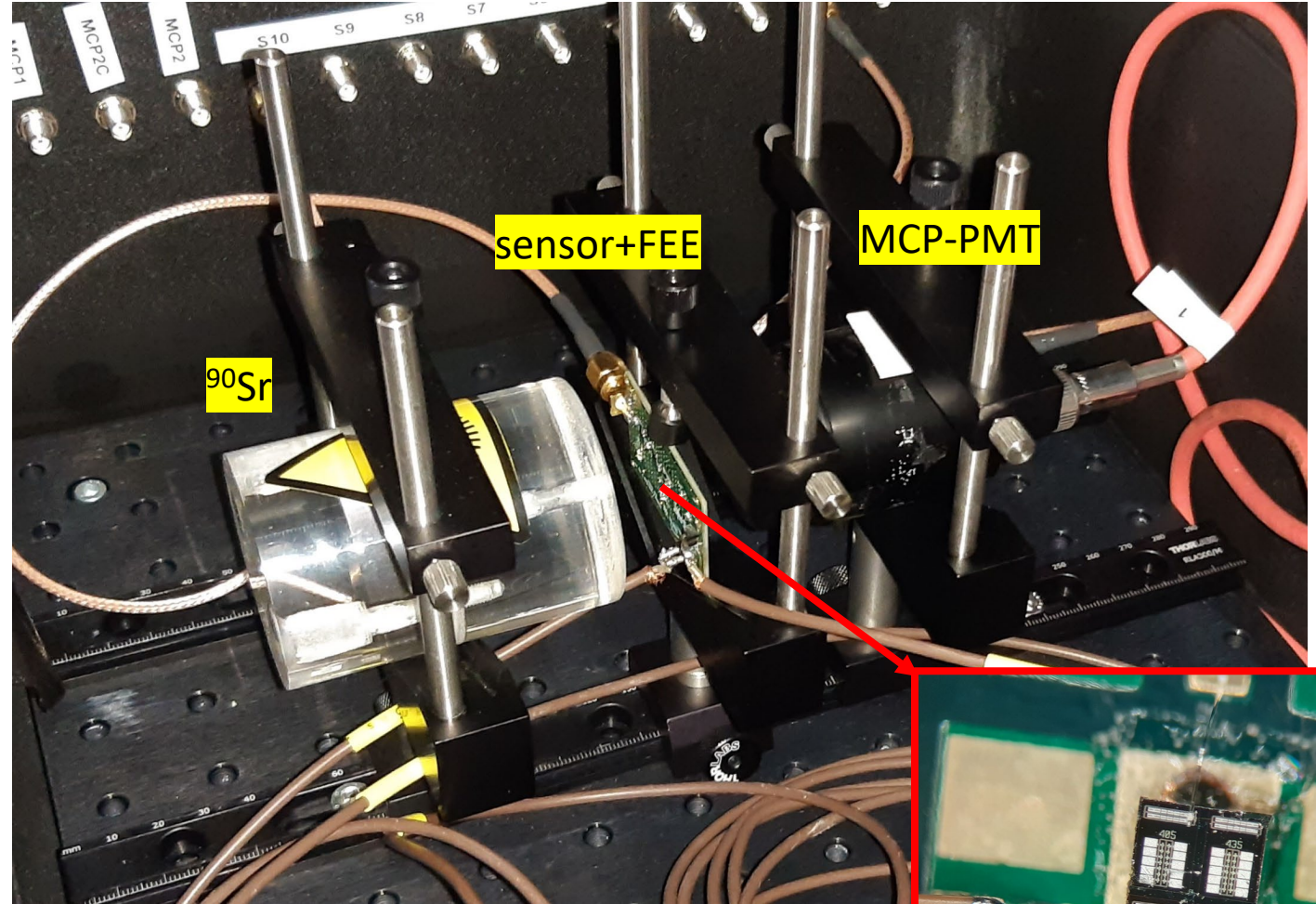
Microchannel plate PMT - Photonis PP0365G



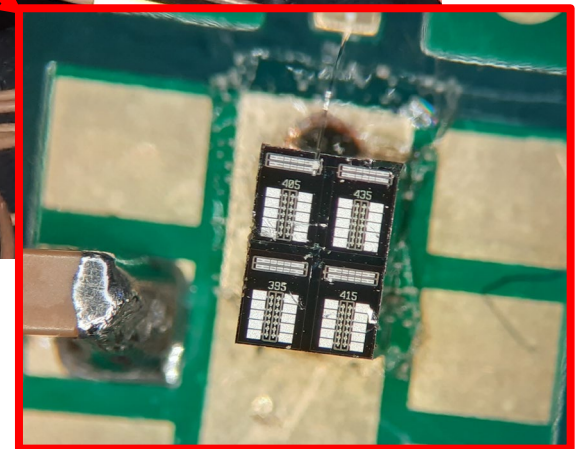
- Input window diameter 18 mm
- $\sim 40$  ps Transit Time Spread (TTS) in single photon condition
- 2 MCP, chevron
- $6 \mu\text{m}$  channel size, L:D 50:1

# Setup I

The setup is inside a **light tight black box**.

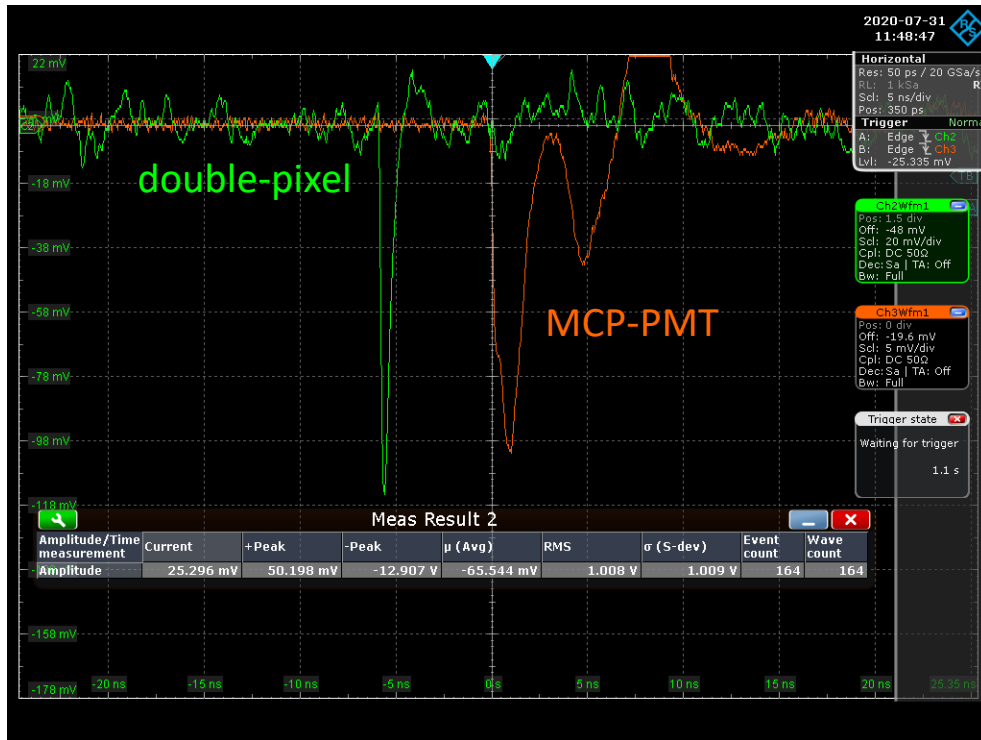


The pad in which the sensor is taped has an hole to avoid the electrons from losing energy in the PCB.



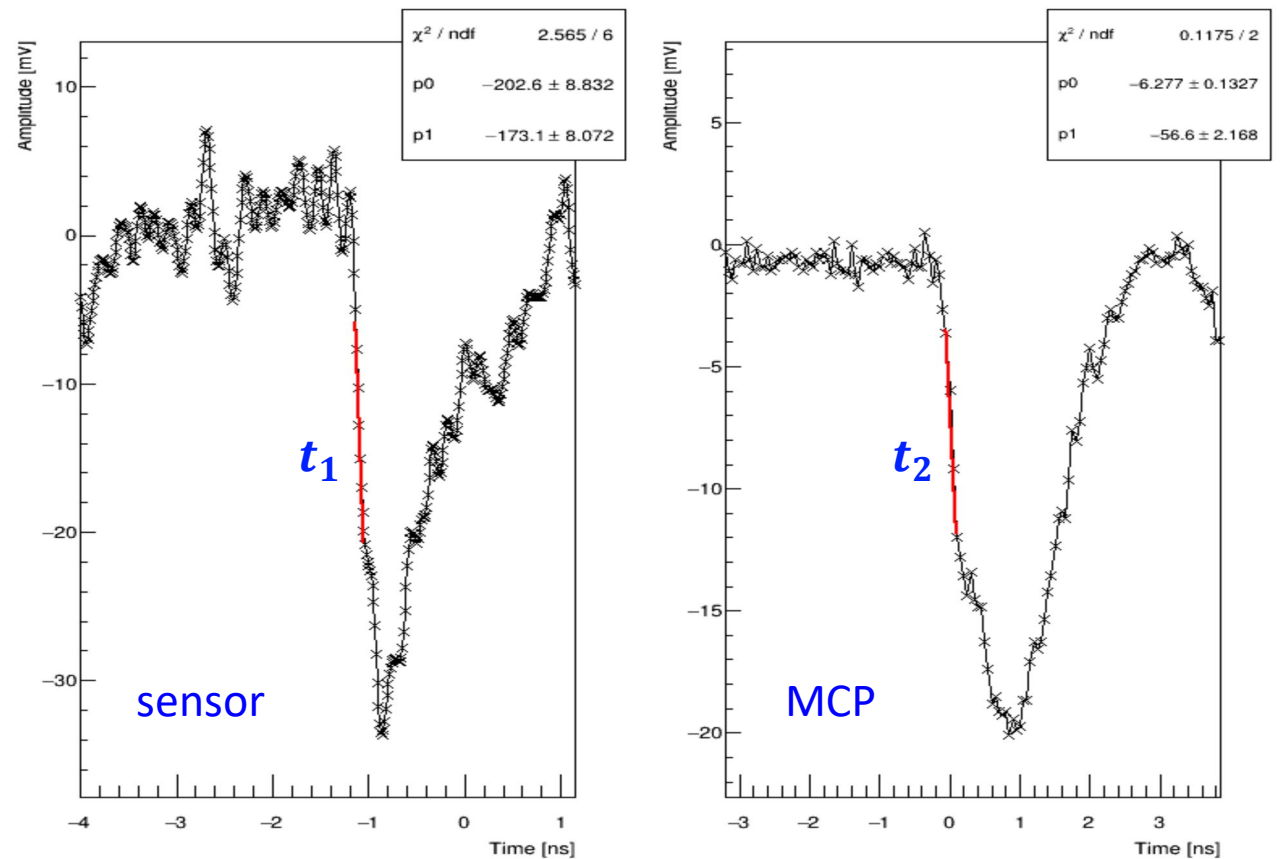
# Analysis

A typical event seen at the oscilloscope



$$\Delta t = t_{\text{sensor}} - t_{\text{mcp}} \longrightarrow \sigma_{\text{sensor}}$$

- Offline analysis of the waveforms acquired with the oscilloscope
- Offline interpolation
- Constant fraction algorithm to determine the ToA

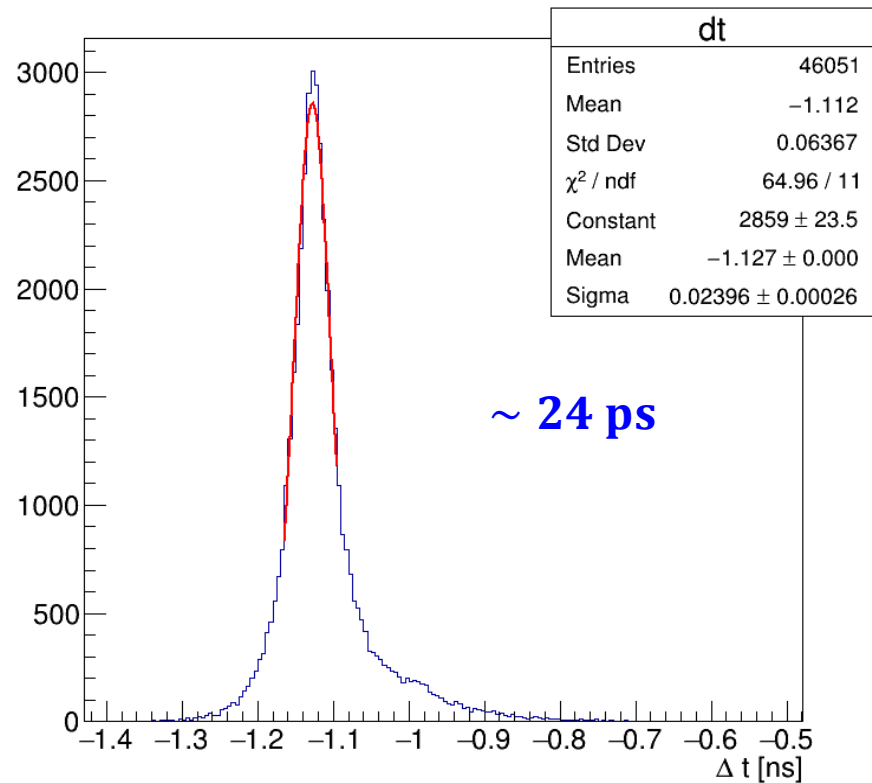


# Time resolution – setup I

$$\Delta t = t_{\text{sensor}} - t_{\text{mcp}}$$

TimeSPOT 3D double pixel

$V_{\text{bias}} = -100 \text{ V}$



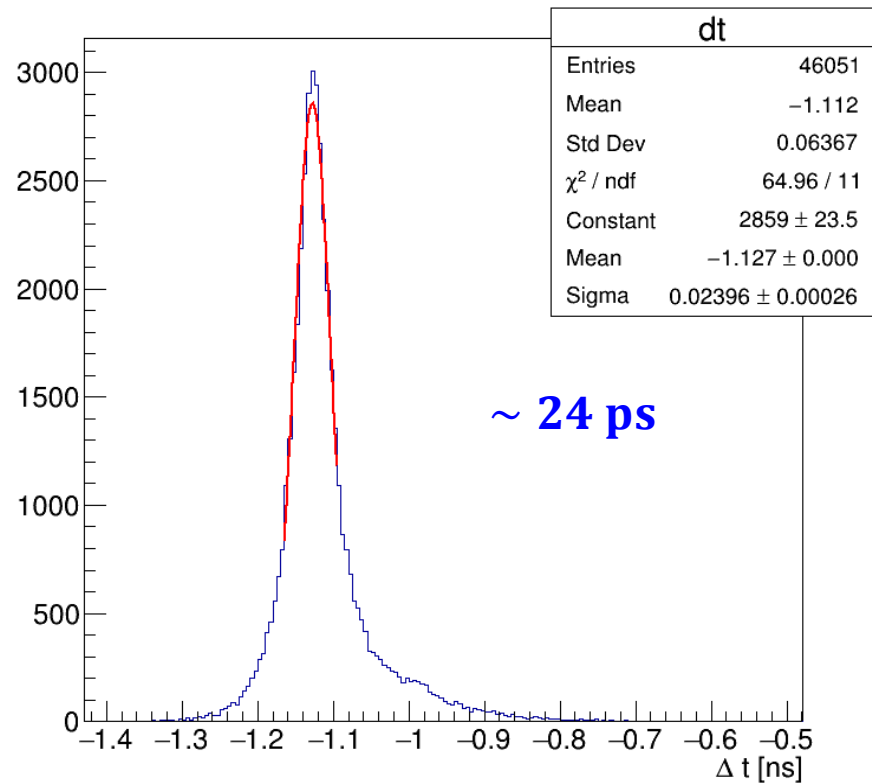
Compatible with the beam test results

# Time resolution – setup I

$$\Delta t = t_{\text{sensor}} - t_{\text{mcp}}$$

## TimeSPOT 3D double pixel

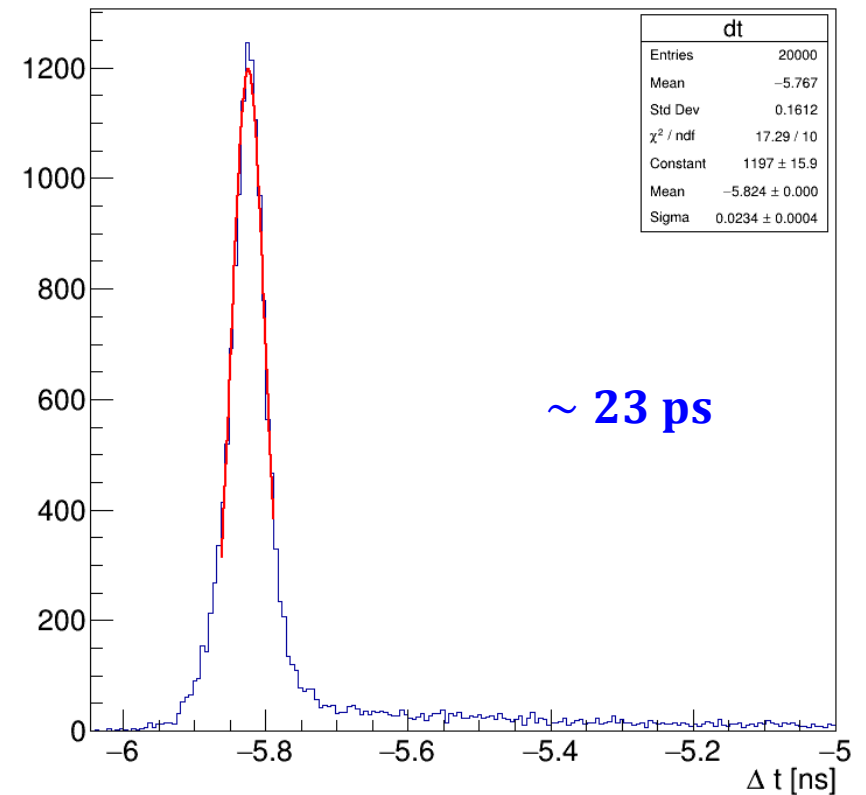
$V_{\text{bias}} = -100 \text{ V}$



Compatible with the beam test results

## TimeSPOT 3D strip pixel

$V_{\text{bias}} = -100 \text{ V}$

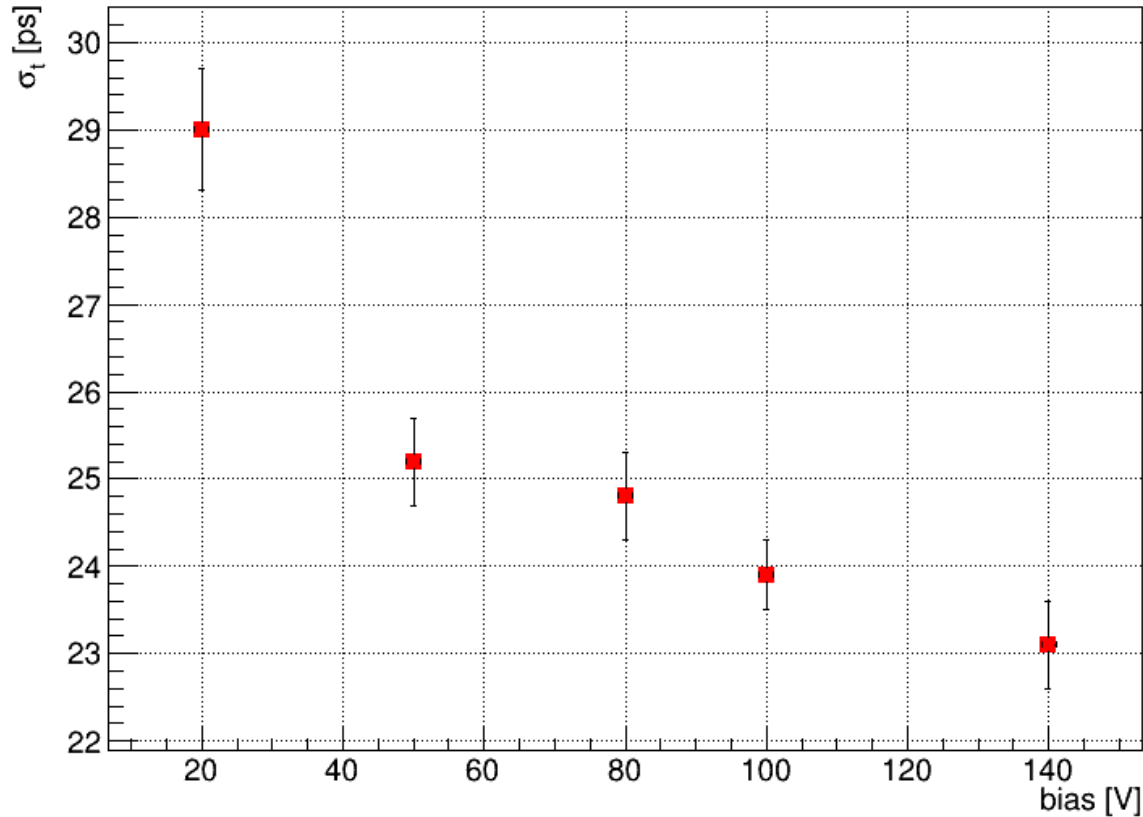


Not measured at the beam test!

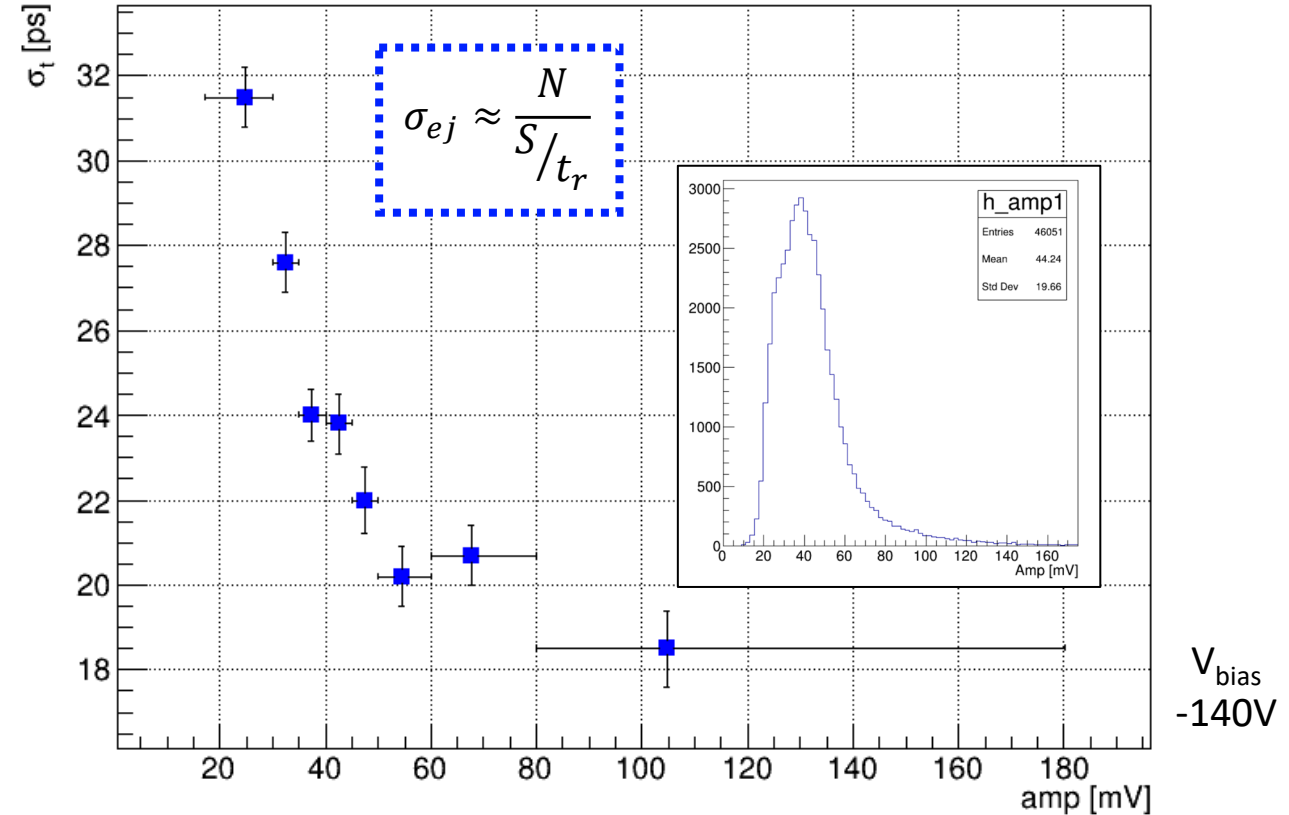
# Time resolution – setup I

$$\Delta t = t_{double-pixel} - t_{mcp} \longrightarrow \sigma_t \quad \sigma_t \cong \sqrt{\sigma_{un}^2 + \sigma_{ej}^2}$$

Time resolution VS bias



Time resolution VS signal amplitude



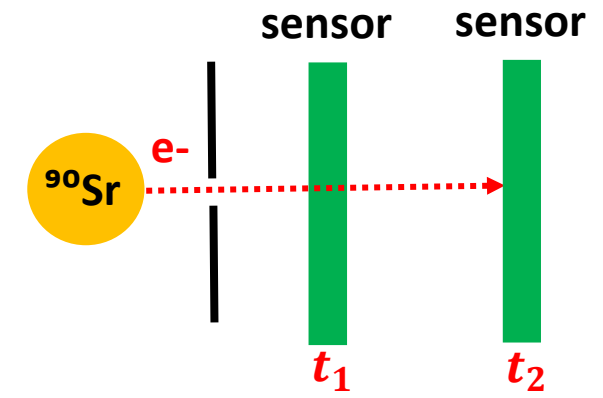
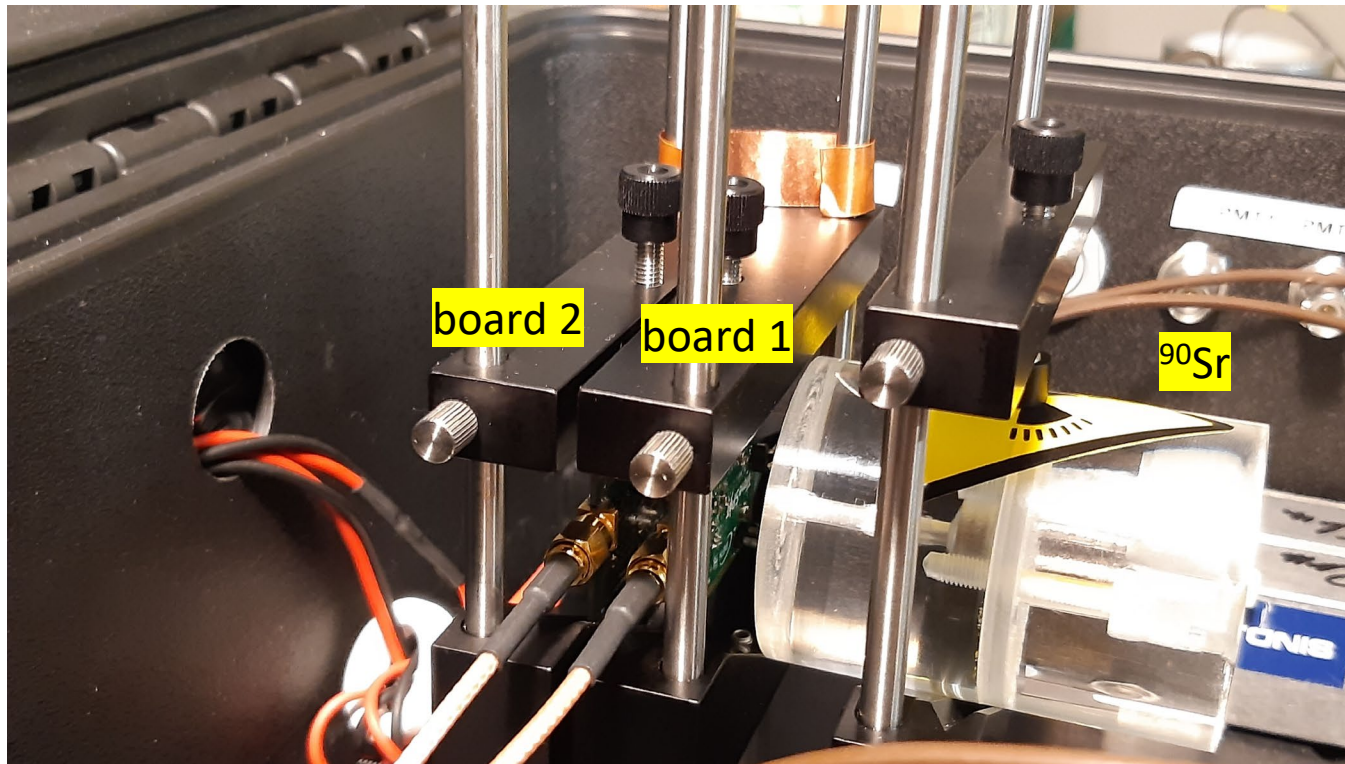
Same trend expected and observed also at the beam test.

With an amplitude scan we can study the impact of the front-end electronics to the time resolution.

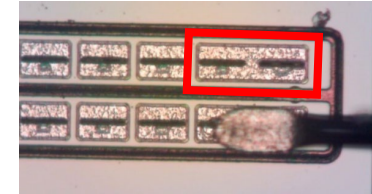


# Setup II

- It simplifies the setup, making the measurement independent of the MCP-PMT
- This measurement wasn't done at the PSI 2019 beam test

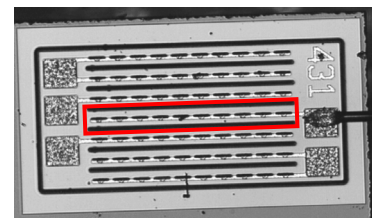


board 1 → double pixel



$55 \times 110 \mu\text{m}^2$

board 2 → strip pixel



$55 \times 550 \mu\text{m}^2$

The sensors are very small, but the multiple scattering in the first sensor makes the alignment not so critical.

# Time resolution - Setup II

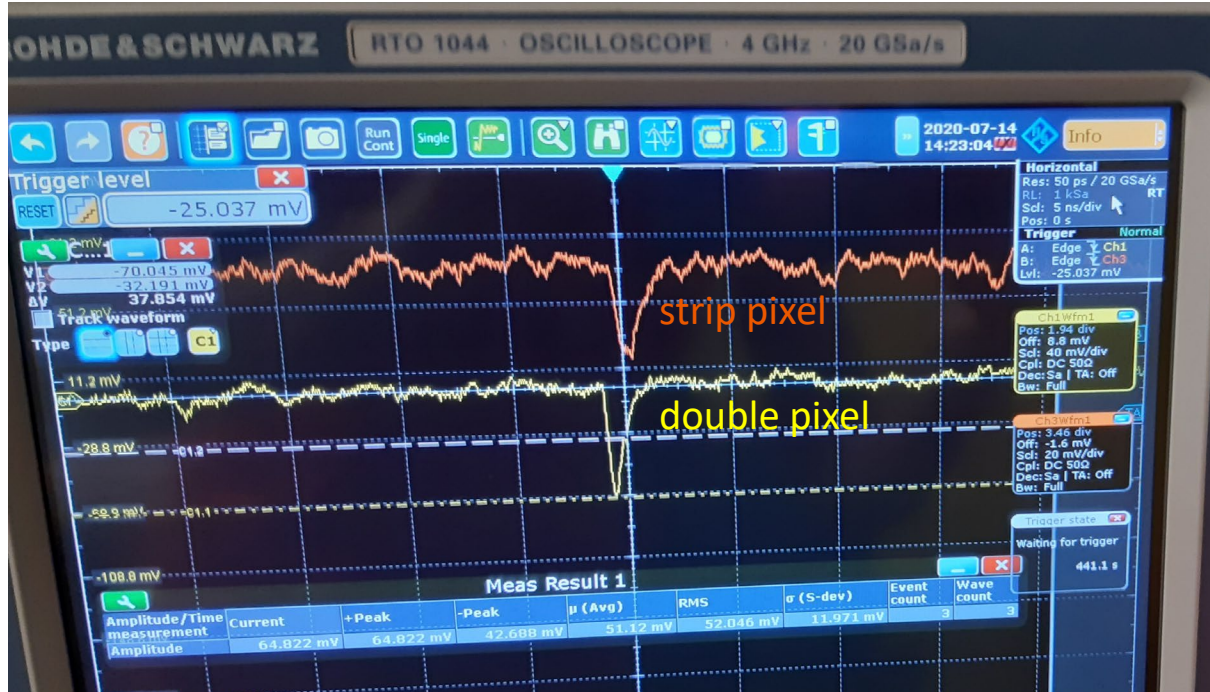
A typical event at the oscilloscope



- Acquisition of the waveforms with the oscilloscope
- Offline analysis
- Constant fraction algorithm described before to determine the ToA of each signal

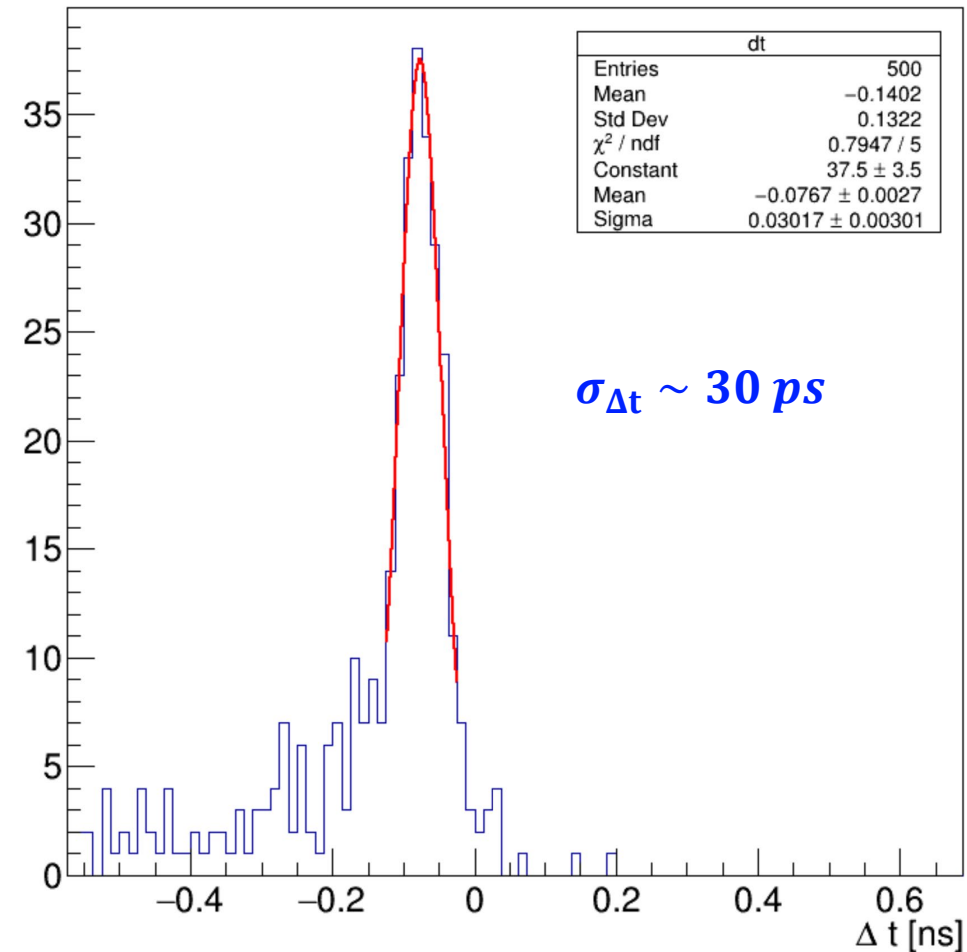
# Time resolution - Setup II

A typical event at the oscilloscope



- Acquisition of the waveforms with the oscilloscope
- Offline analysis
- Constant fraction algorithm described before to determine the ToA of each signal

$$\Delta t = t_{\text{double-pixel}} - t_{\text{strip}}$$



# Comparison with the PSI beam test

Three measurements:

- $t_{\text{double-pixel}} - t_{\text{mcp}}$
- $t_{\text{strip}} - t_{\text{mcp}}$
- $t_{\text{double-pixel}} - t_{\text{strip}}$

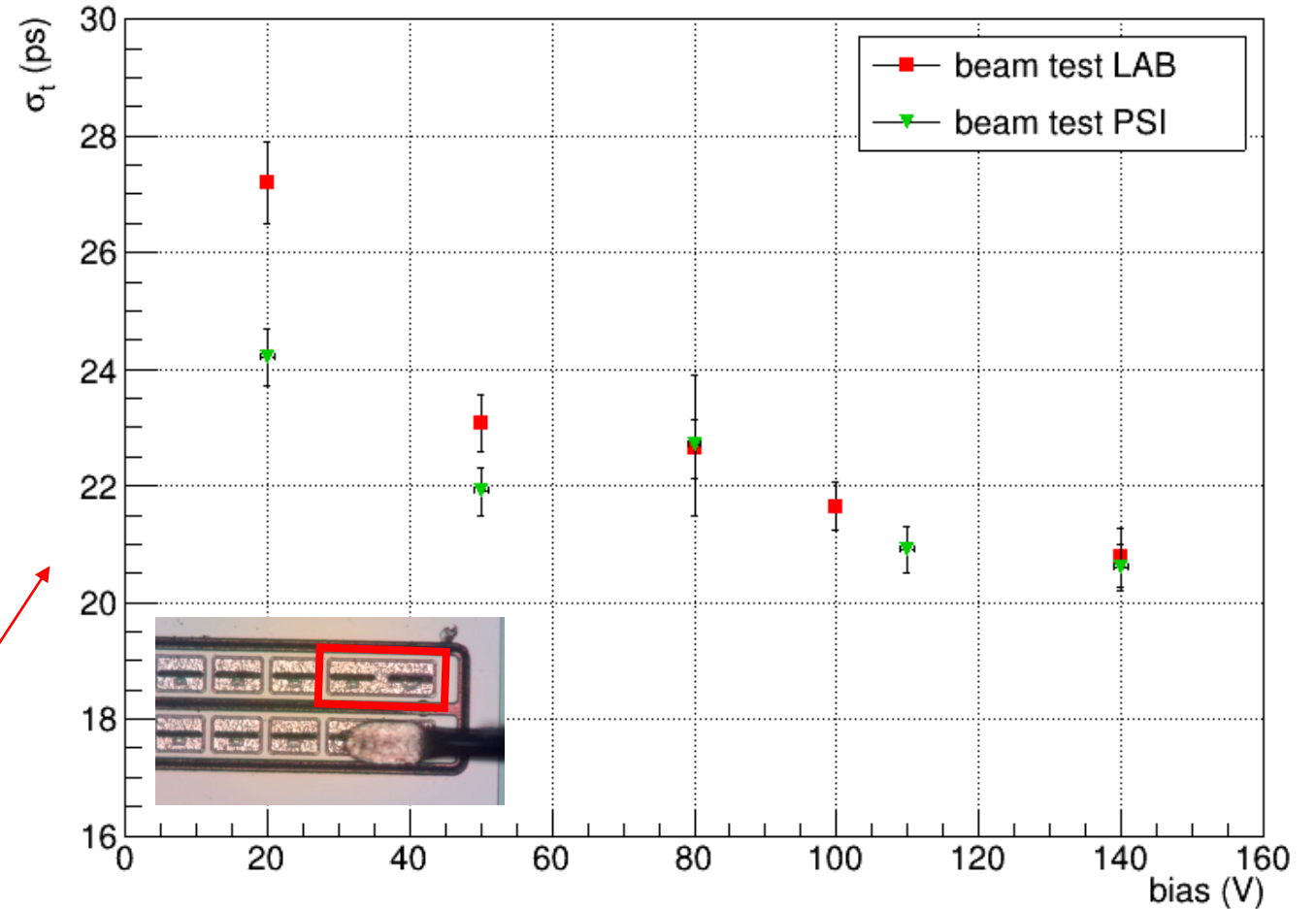
We can derive the time resolution of each detector...

$$\sigma_{\text{mcp}} \sim 10.3 \text{ ps}$$

$$\sigma_{\text{double-pixel}} \sim 21.6 \text{ ps}$$

$$\sigma_{\text{strip}} \sim 21.0 \text{ ps}$$

and **subtract the contribution of the MCP.**



# Conclusions and outlook

- Beam test like setup with a  $^{90}\text{Sr}$  source
- **Very good agreement** with the PSI beam test results  $\longrightarrow$  about 21 ps time resolution
- **Irradiated TimeSPOT sensors** tests are planned
- Soon second TimeSPOT sensors batch and two more performant MCP-PMT
- The results obtained with this setup do not give information about the efficiency of the pixel  $\longrightarrow$  a **microscopic** amplitude and time characterization is mandatory to study the detailed sensors response ([see Andrea's talk, following](#))